Power MOSFET

40 V, Single N-Channel, 101 A DPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- MSL 1/260°C
- AEC O101 Oualified
- 100% Avalanche Tested
- AEC Q101 Qualified NVD5802N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Motor Driver

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	Gate-to-Source Voltage				V
Continuous Drain Cur-		T _C = 25°C	I _D	101	Α
rent (R _{θJC}) (Note 1)		T _C = 85°C		78	
Power Dissipation $(R_{\theta JC})$ (Note 1)	Steady	T _C = 25°C	P_{D}	93.75	W
Continuous Drain Cur-	State	T _A = 25°C	I _D	16.4	Α
rent (R _{θJA}) (Note 1)		T _A = 85°C		12.7	
Power Dissipation $(R_{\theta JA})$ (Note 1)		T _A = 25°C	P_{D}	2.5	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	300	Α
Current Limited by Packa	I _{DmaxPkg}	45	Α		
Operating Junction and S	T _J , T _{stg}	-55 to 175	°C		
Source Current (Body Diode)			I _S	50	Α
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 32 V, V_{GS} = 10 V, L = 0.3 mH, $I_{L(pk)}$ = 40 A, R_G = 25 Ω)			E _{AS}	240	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T_L	260	°C

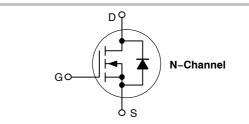
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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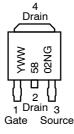
V _{(BR)DSS}	R _{DS(on)}	I _D	
40 V	4.4 mΩ @ 10 V	101 A	
	$7.8~\text{m}\Omega$ @ $5.0~\text{V}$	50 A	





CASE 369C DPAK (Bent Lead) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENT



Y = Year WW = Work Week 5802N = Device Code G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.6	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	60	
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	105	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 10 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				40		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 40 \text{ V}$	T _J = 150°C			50	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		3.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-7.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_O = 50 A		3.6	4.4	mΩ
		V _{GS} = 5.0 V, I _D = 50 A			6.5	7.8	1
Forward Transconductance	gFS	V _{DS} = 15 V, I _D = 15 A			16.8		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			5300		pF
Output Capacitance	C _{oss}				850		7
Reverse Transfer Capacitance	C _{rss}				550		1
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			5025		pF
Output Capacitance	C _{oss}				580		
Reverse Transfer Capacitance	C _{rss}				400		1
Total Gate Charge	Q _{G(TOT)}				75	100	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _I	ns = 15 V,		6.0		1
Gate-to-Source Charge	Q _{GS}	$I_{D} = 50 \text{ A}$			18		1
Gate-to-Drain Charge	Q_{GD}				15		1
SWITCHING CHARACTERISTICS (Not	e 4)		•				
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 20 V, I_{D} = 50 A, R_{G} = 2.0 Ω			14		ns
Rise Time	t _r				52		1
Turn-Off Delay Time	t _{d(off)}				39		1
Fall Time	t _f				8.5		7

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 50 A	T _J = 25°C		0.9	1.2	V
		V _{GS} = 0 V, I _S = 20 A	T _J = 25°C		0.8	1.0	
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dls/dt = 100 A/ μ s, I_{S} = 50 A			25		ns
Charge Time	ta				15		
Discharge Time	tb				10		1
Reverse Recovery Charge	Q_{RR}				15		nC

TYPICAL PERFORMANCE CHARACTERISTICS

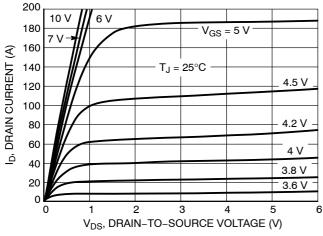


Figure 1. On-Region Characteristics

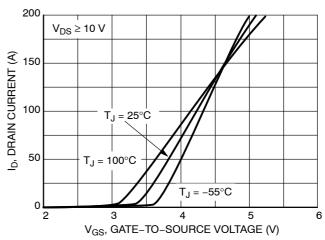


Figure 2. Transfer Characteristics

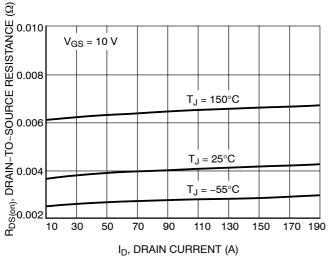


Figure 3. On-Resistance vs. Drain Current

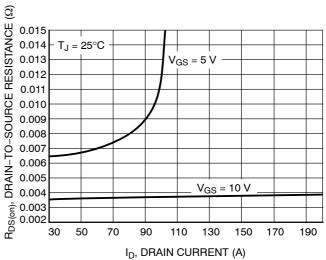


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

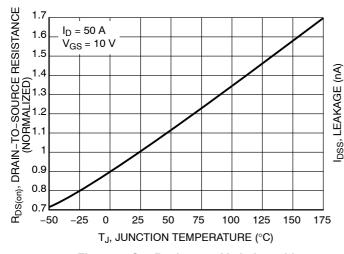


Figure 5. On–Resistance Variation with Temperature

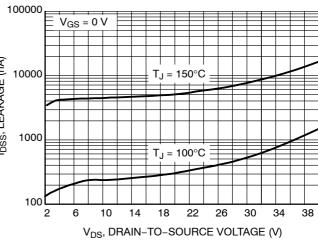


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CHARACTERISTICS

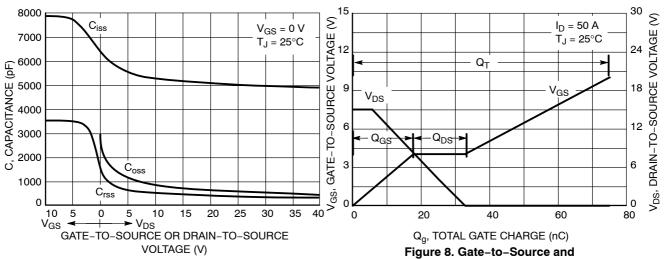


Figure 7. Capacitance Variation

Drain-to-Source Voltage vs. Total Charge

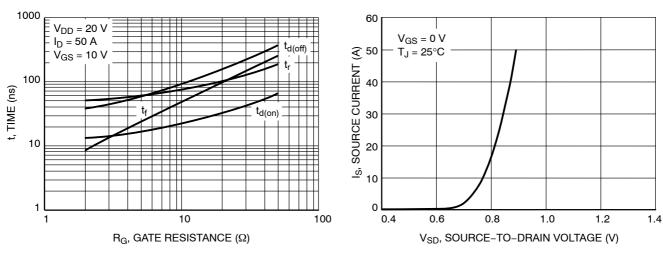


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

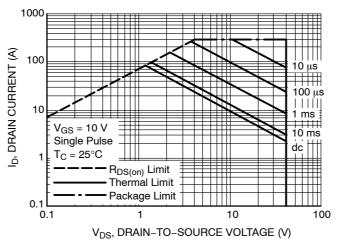


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL PERFORMANCE CHARACTERISTICS

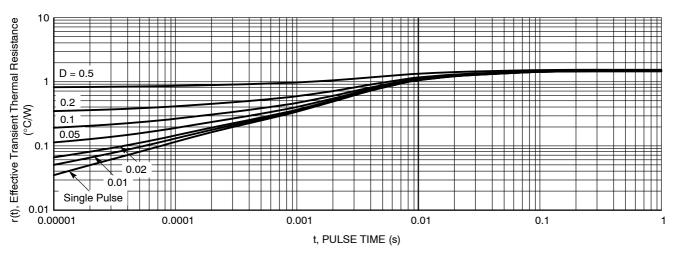


Figure 12. Thermal Response

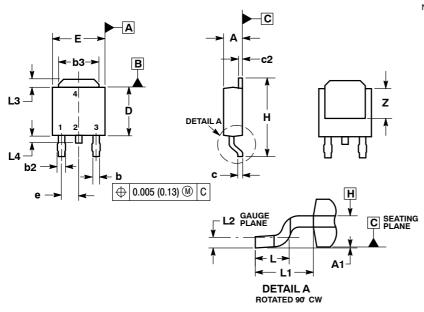
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD5802NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5802NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE D



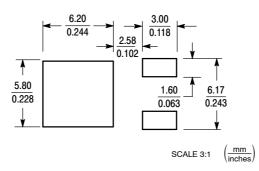
NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
- 2 CONTROLLING DIMENSION: INCHES
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3. L3 and Z.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H

	INC	HES	MILLIMETERS			
DIM	MIN	MIN MAX		MAX		
Α	0.086	0.094	2.18	2.38		
A1	0.000	0.005	0.00	0.13		
b	0.025	0.035	0.63	0.89		
b2	0.030	0.045	0.76	1.14		
b3	0.180	0.215	4.57	5.46		
С	0.018	0.024	0.46	0.61		
c2	0.018	0.024	0.46	0.61		
D	0.235	0.245	5.97	6.22		
Е	0.250	0.265	6.35	6.73		
е	0.090	BSC	2.29 BSC			
Н	0.370	0.410	9.40	10.41		
L	0.055	0.070	1.40	1.78		
L1	0.108	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC			
L3	0.035	0.050	0.89	1.27		
L4		0.040		1.01		
Z	0.155		3.93			

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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